

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 264751US90PCT		SERIAL NO. 10/521,592	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Kazushige OHNO, et al.			
				FILING DATE January 18, 2005		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	4 276 071	06/30/81	OUTLAND (equivalent of JP 56124418 -with English abstract)			
	AB	4 364 761	12/21/82	BERG et al. (equivalent of JP 56124417 -with English abstract & JP 62096717 -with English abstract)			
	AC	4 416 676	11/22/83	MONTIERTH			
	AD	4 417 908	11/29/83	PITCHER (equivalent of JP 58196820 -with English abstract & JP 349608 & EP 0089751)			
	AE	4 420 316	12/13/83	FROST et al.			
	AF	2003/0041730	03/06/03	BEALL et al. (equivalent of US 6696132 & WO 03/020407)			
	AG	4 643 749	02/17/87	MIURA (equivalent of JP 61424 - with English abstract)			
	AH	4 857 089	08/15/89	KITAGAWA et al. (equivalent of JP 63185425 -with English abstract & EP 0277012)			
	AI	2003/0167755	09/11/03	NAKATANI et al. (equivalent of JP 200349627-with English abstract & WO 03014539)			
	AJ	6 395 370	05/28/02	NODA et al. (equivalent of JP 2001206780-with English abstract, WO 0153232-with English abstract & EP 1174399)			
	AK	5 545 243	08/13/96	KOTANI et al. (equivalent of JP 7163823-with English abstract & EP 0658363)			
	AL	2002/0180117	12/05/02	YAMAMOTO et al. (equivalent of US 6716512, JP 2001199777-with English abstract & EP 1170270)			
	AM	2004/0097370	05/20/04	ICHIKAWA et al. (equivalent of JP 2003155908-with English abstract, WO 03044338-with English abstract & EP 1447535)			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AN	58-92409	06/22/83	JP (with partial English translation)			NO
	AO	58-150015	09/06/83	JP (with English abstract)			NO
	AP	5-68828	03/23/93	JP (with English abstract & equivalent of JP 3130587)			NO
	AQ	2 789 327	08/11/00	FR (with English abstract)			NO
	AR	02/100514	12/19/02	WO (with English abstract & equivalent of JP 2001-334114 - with English abstract)			NO
	AS	02/10562	02/07/02	WO (with English abstract & equivalent of DE 10037403)			NO
	AT	03/080218	10/02/03	WO (with English abstract & equivalent of JP 2004896 - with English abstract)			NO
	AU	2 840 545	12/12/03	FR (with English abstract)			NO
					<input checked="" type="checkbox"/> Additional References sheet(s) attached		
Examiner /Lessanetwork Seifu/					Date Considered 05/27/2008		

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /L.S./

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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AV	01/23069	04/05/01	WO (with English abstract & equivalent of JP 2001162121 -with English abstract & EP 1142619)			NO
	AW	3-102016	10/24/91	JP (with partial English translation)			NO
	AX	2003-1029	01/07/03	JP (with English abstract)			NO
	AY	6-47620	06/28/94	JP (with partial English translation)			NO
	AZ	2001-96117	04/10/01	JP (with English abstract)			NO
	AAA						
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